

**Notice of References Cited**Application/Control No.  
**09/845,080**Applicant(s)/Patent Under Reexam  
**Naimark et al.**Examiner  
**Dave Nguyen**Art Unit  
**1632**

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**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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